

<b>Notice of References Cited</b>	Application/Control No. 10/799,595		Applicant(s)/Patent Under Reexamination OKUMURA ET AL.	
	Examiner Thomas M. Dougherty		Art Unit 2834	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,380,660	04-2002	Maeno et al.	310/323.02
*	B	US-6,819,029	11-2004	Ohno et al.	310/323.17
*	C	US-6,723,106	04-2004	Charles et al.	606/130
*	D	US-4,523,120	06-1985	Assard et al.	310/323.17
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-2000-055664	02-2000	Japan	Aoyanagi et al.	G01C 17/38
	O	JP-2001-276091	10-2001	Japan	Nobuhito et al.	A61B 19/00
	P	WO-00-30186	11-1999	PCT	Andersen et al.	H01L 41/09
	Q	JP-11-090867	04-1999	Japan	Takeshi	B25J 7/00
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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